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| Notice of References Cited | Application/Control No. 09/823,759 | Applicant(s)/Patent Under Reexamination YEN ET AL. | |
| | Examiner Nhon (Gary) D Nguyen | Art Unit 2179 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,801,507 B1 | 10-2004 | Humpleman et al. | 370/257 |
| | B | US-5,887,193 A | 03-1999 | Takahashi et al. | 710/8 |
| | C | US-5,956,487 A | 09-1999 | Venkatraman et al. | 709/218 |
| | D | US-6,032,202 A | 02-2000 | Lea et al. | 710/8 |
| | E | US-6,044,403 A | 03-2000 | Gerszberg et al. | 709/225 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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